## Notice of References Cited Application/Control No. 10/672,304 Examiner Tai Duong Applicant(s)/Patent Under Reexamination CHO ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0025868	02-2003	Hiroshima et al.	349/156
*	В	US-6,317,187	11-2001	Nakajima et al.	349/155
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	J	US-			
	К	US-			
	L	US-		·	
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## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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